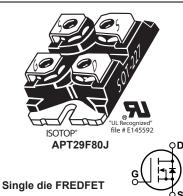




800V, 29A, 0.21Ω Max, t_{rr} ≤370ns

N-Channel FREDFET

POWER MOS 8° is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced t_{rr} , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C_{rss}/C_{iss} result in excellent niose immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



FEATURES

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- · ZVS phase shifted and other full full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
1	Continuous Drain Current @ T _C = 25°C	31	
'D	Continuous Drain Current @ T _C = 100°C	19	Α
I _{DM}	Pulsed Drain Current ¹	173	
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy ²	1979	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	24	Α

Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit	
P _D	Total Power Dissipation @ T _C = 25°C			543	W	
R _{0JC}	Junction to Case Thermal Resistance			0.23	0.23 °C/W	
R _{ecs}	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15			
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55		150	°C	
V _{Isolation}	RMS Voltage (50-60hHz Sinusoidal Wavefomr from Terminals to Mounting Base for 1 Min.)	2500			V	
W _T	W Basis Waish		1.03		oz	
· · · · ·	Package Weight		29.2		g	
Torque	Terminals and Mounting Screws.			10	in·lbf	
				1.1	N·m	

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	V _{GS} = 0V,	800			V	
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D = 250μA			1.41		V/°C
R _{DS(on)}	Drain-Source On Resistance 3	V _{GS} = 10V, I _D = 24A			0.19	0.21	Ω
V _{GS(th)}	Gate-Source Threshold Voltage	- V _{GS} = V _{DS} , I _D = 2.5mA		2.5	4	5	V
$\Delta V_{GS(th)} / \Delta T_{J}$	Threshold Voltage Temperature Coefficient				-10		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = 800V	T _J = 25°C			250	μA
DSS		V _{GS} = 0V	T _J = 125°C			1000] μΑ
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±30V			·	±100	nA

Dynamic Characteristics

T_{.I} = 25°C unless otherwise specified

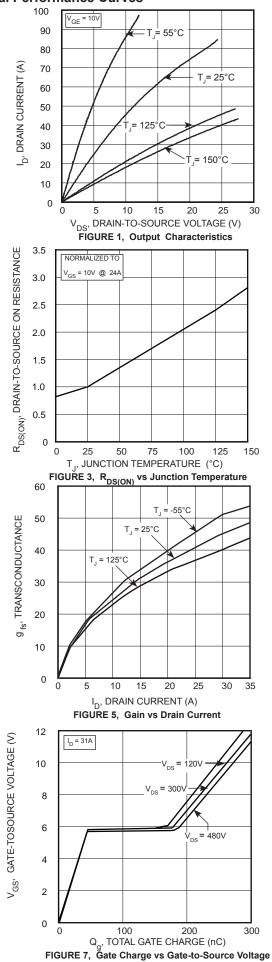
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Symbol	Parameter	Test Conditions Min		Тур	Max	Unit	
g _{fs}	Forward Transconductance	$V_{DS} = 50V, I_D = 24A$		43		S	
C _{iss}	Input Capacitance	V - 0V V - 05V		9326			
C _{rss}	Reverse Transfer Capacitance	V _{GS} = 0V, V _{DS} = 25V f = 1MHz		159			
C _{oss}	Output Capacitance			927			
C _{o(cr)} ⁴	Effective Output Capacitance, Charge Related	V = 0V V = 0V40 522V		438		pF	
C _{o(er)} 5	Effective Output Capacitance, Energy Related	V _{GS} = 0V, V _{DS} = 0V to 533V		217			
Q _g	Total Gate Charge	V = 0.45.40V L = 0.4A		303			
Q _{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 24A,$		51		nC	
Q _{gd}	Gate-Drain Charge	$V_{DS} = 400V$		155			
t _{d(on)}	Turn-On Delay Time	Resistive Switching		53			
t _r	Current Rise Time	V_{DD} = 533V, I_{D} = 24A		76		ns	
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 2.2\Omega^{\textcircled{6}}, V_{GG} = 15V$		231		115	
t _f	Current Fall Time			67			

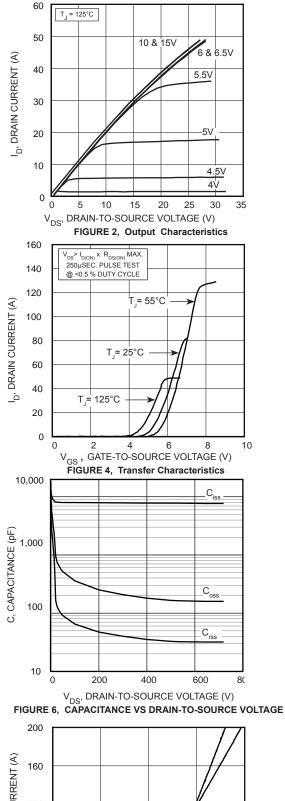
Source-Drain Diode Characteristics

Symbol	Parameter	Test Cond	Min	Тур	Max	Unit	
I _s	Continuous Source Current (Body Diode)	MOSFET symbol showing the	OD O			31	A
I _{sm}	Pulsed Source Current (Body Diode)	integral reverse p-n junction diode (body diode)	G S			173	A
V _{SD}	Diode Forward Voltage	$I_{SD} = 24A, T_J = 25^{\circ}C, V_{GS} = 0V$				1.2	V
t _{rr}	Reverse Recovery Time	I _{SD} = 24A ³ di _{SD} /dt = 100A/μs	T _J = 25°C			370	ns
rr			T _J = 125°C			710	113
Q _{rr}	Reverse Recovery Charge		T _J = 25°C		1.91		μC
rr			T _J = 125°C		5.18		μΟ
	Reverse Recovery Current		T _J = 25°C		12		Α
'rrm		T _J = 125°C			18		^
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 24A$, di/dt $\le 1000A/\mu s$, $V_{DD} = 100V$, $T_{J} = 125^{\circ}C$				25	V/ns

- 1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_{.I}$ = 25°C, L = 6.9mH, R_{G} = 25 Ω , I_{AS} = 24A.
- (3) Pulse test: Pulse Width < 380µs, duty cycle < 2%.
- 4 $\textbf{C}_{\text{o(cr)}}$ is defined as a fixed capacitance with the same stored charge as \textbf{C}_{OSS} with \textbf{V}_{DS} = 67% of $\textbf{V}_{\text{(BR)DSS}}$.
- (a) $C_{o(er)}$ is defined as a fixed capacitance with the same stored energy as C_{OSS} with $V_{DS} = 67\%$ of $V_{(BR)DSS}$. To calculate $C_{o(er)}$ for any value of V_{DS} less than $V_{(BR)DSS}$, use this equation: $C_{o(er)} = -8.27E 7/V_{DS}^2 + 1.01E 7/V_{DS} + 1.43E 10$.
- 6 R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.





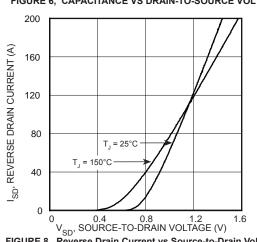
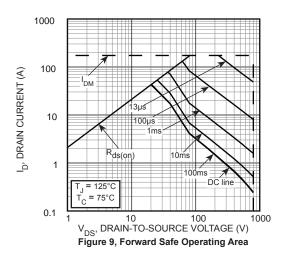
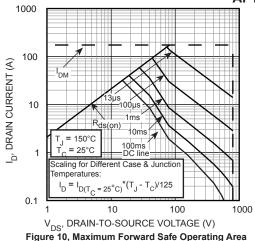
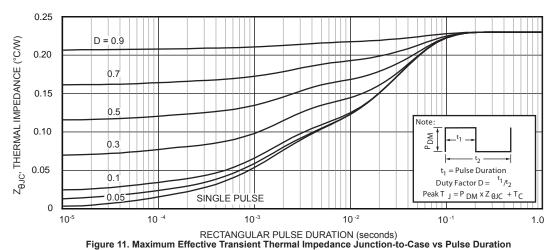


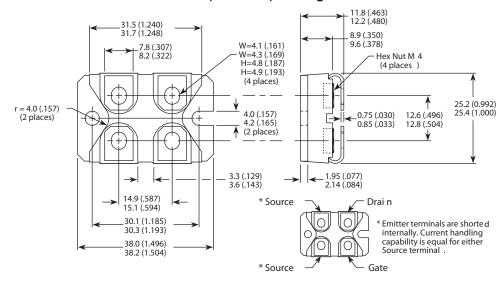
FIGURE 8, Reverse Drain Current vs Source-to-Drain Voltage







SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)